

Search Notes

Application/Control No.

10/609,062

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

VENK, SRIDHARAN

Art Unit

2652

SEARCHED

Class	Subclass	Date	Examiner
Updated		8/19/2005	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR